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Application/Control No.	Applicant(s)/Patent under Reexamination
10/799,148	MIELKE ET AL.
Examiner	Art Unit
Allan Kuhne	1732

	**				
	SEARCHED				
Class	Subclass	Date	Examiner		
264 264	46.5 46.6	11/7/2006	ARK		
264 264	255 258	11/7/2006	ARK		
264 264	102 154	11/7/2006	ARK		
156	245	11/7/2006	ARK		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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